SOT23 N-CHANNEL ENHANCEMENT MODE VERTICAL DMOS FET

BSS138

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PARTMARKING DETAIL   – SS
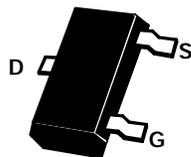
SOT23

ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT
Drain-Source Voltage	V_{DS}	50	V
Continuous Drain Current at T_{amb}=25°C	I_D	200	mA
Pulsed Drain Current	I_{DM}	800	mA
Gate-Source Voltage	V_{GS}	± 20	V
Power Dissipation at T_{amb}=25°C	P_{tot}	360	mW
Operating and Storage Temperature Range	T_j:T_{stg}	-55 to +150	°C

## ELECTRICAL CHARACTERISTICS (at T_{amb} = 25°C unless otherwise stated).

PARAMETER	SYMBOL	MIN.	MIN.	MAX.	UNIT	CONDITIONS.
Drain-Source Breakdown Voltage	BV_{DSS}	50			V	I_D=0.25mA, V_{GS}=0V
Gate-Source Threshold Voltage	$V_{GS(th)}$	0.5		1.5	V	I_D=1mA, V_{DS}= V_{GS}
Gate-Body Leakage	I_{GSS}			100	nA	V_{GS}=± 20V, V_{DS}=0V
Zero Gate Voltage Drain Current	I_{DSS}			0.5 5 100	µA µA nA	V_{DS}=50V, V_{GS}=0 V_{DS}=50V, V_{GS}=0V, T=125°C(2) V_{DS}=20V, V_{GS}=0
Static Drain-Source On-State Resistance (1)	$R_{DS(on)}$			3.5	Ω	V_{GS}=5V,I_D=200mA
Forward Transconductance(1)(2)	g_{fs}	120			mS	V_{DS}=25V,I_D=200mA
Input Capacitance (2)	C_{iss}			50	pF	V_{DS}=25V, V_{GS}=0V, f=1MHz
Common Source Output Capacitance (2)	C_{oss}			25	pF	
Reverse Transfer Capacitance (2)	C_{rss}			8	pF	
Turn-On Delay Time (2)(3)	$t_{d(on)}$		10		ns	V_{DD}≈30V, I_D=280mA
Rise Time (2)(3)	t_r		10		ns	
Turn-Off Delay Time (2)(3)	$t_{d(off)}$		15		ns	
Fall Time (2)(3)	t_f		25		ns	

(1) Measured under pulsed conditions. Width=300µs. Duty cycle ≤2% (2) Sample test.
(3) Switching times measured with 50Ω source impedance and <5ns rise time on a pulse generator

TYPICAL CHARACTERISTICS

Saturation Characteristics
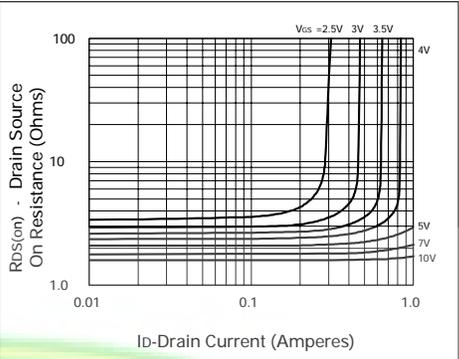
Typical On Resistance vs. Drain Current
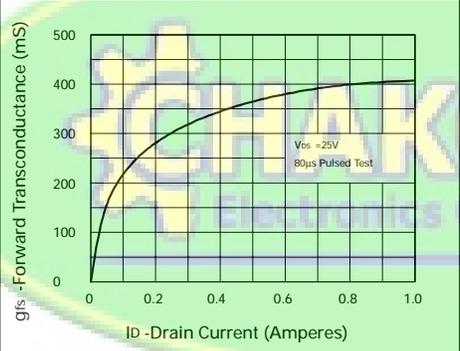
Typical Transconductance vs. Drain Current
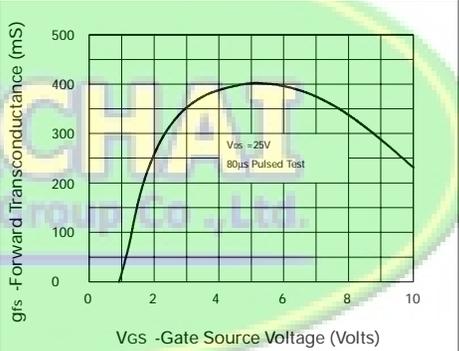
Typical Transconductance vs. Gate - Source Voltage
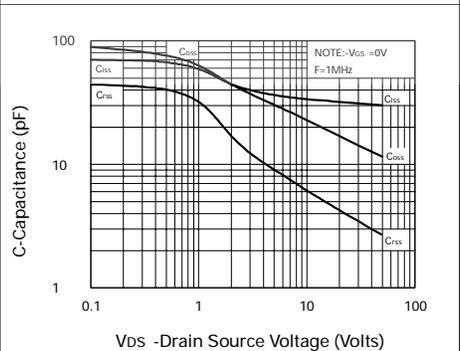
Typical Capacitance vs. Drain - Source Voltage
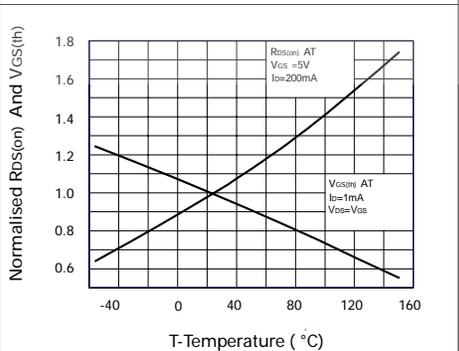
Normalised RDS(on) And VGS(th) vs. Temperature

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TYPICAL CHARACTERISTICS
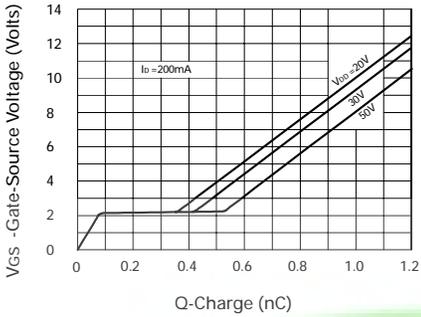
Typical Gate Charge vs. Gate-Source Voltage
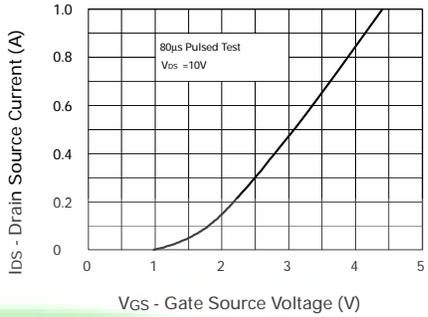
Typical Transfer Characteristics
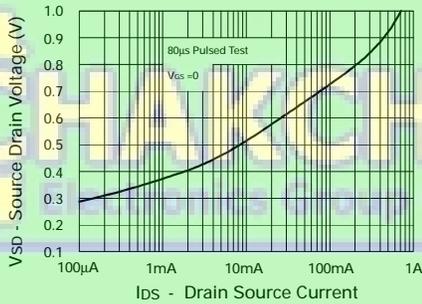
Typical Diode Forward Voltage